

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/781,730	FARQUHAR ET AL.	
		Examiner	Art Unit	
		John L. Goff	1733	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,374,453	12-1994	Swei et al.	427/226
	B	US-4,590,539	05-1986	Sanjana et al.	361/760
	C	US-3,713,870	01-1973	Kaye, Melvin S.	427/383.1
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Computer-Controlled Optical Testing of High-Density Printec-Circuit Board", 1983, IBM J. Res. Develop. Vol 27, pp. 50-58.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.